

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10550369	SASABAYASHI, TAKASHI
Examiner	Art Unit	
DZU LUONG	2871	

SEARCHED

Class	Subclass	Date	Examiner
349	129	2/16/08	Dzu Luong
349	117-121	2/17/08	Dzu Luong

SEARCH NOTES

Search Notes	Date	Examiner
Search strings: 349/129.ccls. and (stripe same (bend\$3 curv\$3)), 349/129.ccls. and (stripe)	2/16/08	Dzu Luong
Assignee search: fujitsu.as. AND (polymeriz\$4)	2/16/08	Dzu Luong
Search strings: (polymeriz\$4) AND (irradiat\$4 NEAR tilt\$4), (liquid adj crystal LC) NEAR (negative adj dielectric adj constant adj anisotropy)	2/17/08	Dzu Luong

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner